

**Notice of References Cited**

Application/Control No.

09/864,497

Applicant(s)/Patent Under

Reexamination

DEAN ET AL.

Examiner

James Mackey

Art Unit

1722

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,269,998	12-1993	Takagi et al.	425/468
	B	US-5,441,397	08-1995	Eriksen et al.	425/116
	C	US-5,664,039	09-1997	Grinderslev et al.	385/65
	D	US-5,707,565	01-1998	Suzuki et al.	425/468
	E	US-5,780,079	07-1998	Lee, Ho-kyung	425/468
	F	US-5,786,002	07-1998	Dean et al.	425/468
	G	US-5,815,621	09-1998	Sakai et al.	385/80
	H	US-6,074,577	06-2000	Katsura et al.	425/468
	I	US-6,287,017	09-2001	Katsura et al.	249/64
	J	US-6,340,247	01-2002	Sakurai et al.	385/78
	K	US-6,342,170	01-2002	Yang, Hsi-Harng	425/468
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.